

**Search Notes**

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Examiner

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Applicant(s)/Patent under  
Reexamination

BUICE ET AL.

Art Unit

2141

**SEARCHED**

Class	Subclass	Date	Examiner
709	219	10/19/2007	DB
709	206	10/19/2007	DB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	10/19/2007	DB
Double Patenting search	10/19/2007	db